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<sup>18</sup>Calculating the standard deviation of  $(R\Delta M)_q$  from  $K$  and  $K^*$  yields an error of 1.4 MeV for  $D^+ - D^0$  and 1.0 MeV for  $D^{*+} - D^{*0}$ .

## Comments on Defect Production and Stoichiometry in A-15 Superconductors

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The dependence of  $T_c$  upon 2-MeV  $^4\text{He}$  damage has been investigated in  $\text{Nb}_3\text{Ge}$ ,  $\text{Nb}_3\text{Sn}$ ,  $\text{V}_3\text{Si}$ , and  $\text{V}_3\text{Ge}$  superconducting thin films. Similar  $T_c$  versus dose plots are observed for all materials. At high doses  $T_c$  saturates at 3.5 K ( $\text{Nb}_3\text{Ge}$ ), 2.95 K ( $\text{Nb}_3\text{Sn}$ ), 2.2 K ( $\text{V}_3\text{Si}$ ), and 1.0 K ( $\text{V}_3\text{Ge}$ ). Optimum values of  $T_c$  are obtained for Nb:Ge and Nb:Sn ratios throughout the compositional range of 2.6:1–3:1 in 95% single-phase A15 films.

Superconductivity in the A15 materials is a subject of continuing interest with the crucial question being what determines or limits the superconducting transition temperature  $T_c$ . There have been several recent Letters<sup>1,2</sup> and publications<sup>3,4</sup> which address various aspects of this problem. Sweedler, Schweitzer, and Webb<sup>1</sup> were the first to show a universal behavior of  $T_c$  versus neutron damage curves for the A15 materials. They correlated the density of antisite (or antistructure) defects (i.e., interchange of A and B sites) with degradation in  $T_c$ . For example, in their analysis<sup>3</sup> of  $\text{Nb}_3\text{Al}$  when 7.3% of the Nb chains were occupied by Al atoms,  $T_c$  was degraded from 18.6 to 9.6 K.

We had previously examined the  $\text{Nb}_3\text{Ge}$  system in detail with regard to stoichiometry versus  $T_c$  and  $^4\text{He}$  damage versus  $T_c$  dependences.<sup>2,4</sup> Significant differences emerged from our results and those of the Brookhaven National Laboratory group. It did not appear that simple antistructure defects were solely the culpable defects with regard to  $T_c$  degradation as stoichiometries could be varied so that 5% of the Nb chains were occu-

ried by Ge while maintaining  $T_c \sim 20$  K. While the general features of the  $^4\text{He}$  and neutron damage curves agreed well, there were two significant differences. Firstly,  $^4\text{He}$  damage in  $\text{Nb}_3\text{Ge}$  produced a saturated region in  $T_c$  after high doses at  $T_c \sim 3.5$  K and this did not degrade with increasing dose; the neutrons appeared to depress  $T_c$  below 1.5 K with no saturation region.<sup>5</sup> Secondly, the transition widths in the intermediate region, where  $T_c$  was rapidly degrading with dose, were found to increase significantly for  $^4\text{He}$  damage but not for neutron damage.

In this communication we briefly report extensions of our measurements into the following A15 materials:  $\text{Nb}_3\text{Ge}$ ,  $\text{Nb}_3\text{Sn}$ ,  $\text{V}_3\text{Si}$ , and  $\text{V}_3\text{Ge}$ . The motivation was to determine trends and to establish whether the Nb-Ge results were pathological or indeed representative of universal behavior in the A15 materials. Ion-beam and x-ray diffraction techniques<sup>2,4</sup> were used to analyze the films and to induce defects. The  $\text{V}_3\text{Si}$  and  $\text{V}_3\text{Ge}$  films were prepared, in the dc getter-sputtering system described previously<sup>4</sup> with composition ratios of 3:1. The majority of the  $\text{Nb}_3\text{Sn}$  films were

produced at Stanford University using the dual-electron-beam codeposition technique.<sup>6</sup> Films of varying composition were produced by this technique. All films, whether sputter or *e*-beam produced, were deposited on clean sapphire substrates held at temperatures typically in the range 700–800°C. Film thicknesses were in the range 2000–3000 Å.

Standard four-probe resistance measurements were made using pressure, silver paste, or soldered contacts. Temperatures were measured to an accuracy of  $\pm 0.2$  K with calibrated carbon and germanium resistors and/or silicon diodes.  $T_c$ 's below 4 K were determined by pumping on the <sup>4</sup>He in the Dewar and measuring the He vapor pressure (the width of the superconducting transition is taken as 95–5% of the normal state resistance and  $T_c$  is the midpoint). For damage production the samples were irradiated with 2-MeV <sup>4</sup>He particles at a typical particle density of  $3 \times 10^{15} \text{ cm}^{-2} \text{ sec}^{-1}$  ( $1 \mu\text{A } ^4\text{He}^+$  on 2 mm beam-spot size). It should be noted that no <sup>4</sup>He lodges in the films but penetrates  $\sim 5 \mu\text{m}$  into the sapphire substrates. The beam was swept both vertically and horizontally over a defining collimator of  $5.5 \times 5.5 \text{ mm}^2$ . It is believed that the integrated dose is constant to within 5% over this area. Sample temperatures rose to no greater than 50°C during ir-

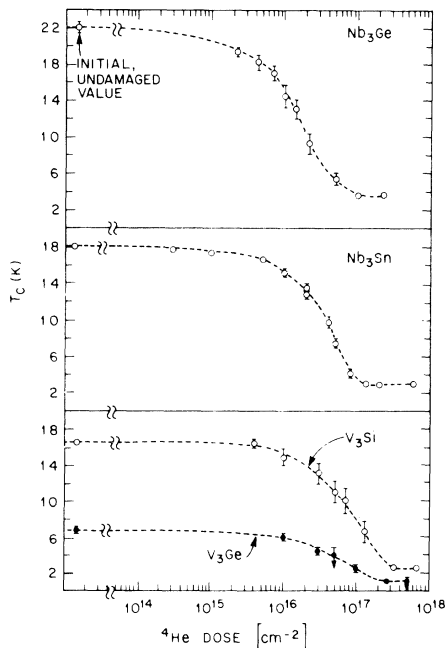


FIG. 1.  $T_c$  vs 2-MeV <sup>4</sup>He bombardment dose for  $\text{Nb}_3\text{Ge}$ ,  $\text{Nb}_3\text{Sn}$ ,  $\text{V}_3\text{Si}$ , and  $\text{V}_3\text{Ge}$ . Dashed lines are only meant to guide the eye.

TABLE I.  $T_c$  values for initial and final states. Transition widths less than or of the order 1 K.

	$T_c$ (initial) (K)	$T_c$ (saturated) (K)
$\text{Nb}_3\text{Ge}$	22	3.5
$\text{Nb}_3\text{Sn}$	18.1	2.95
$\text{V}_3\text{Si}$	16.8	2.2
$\text{V}_3\text{Ge}$	6.5	1.0

radiations. Irradiations were carried out at pressures of  $10^{-7}$  Torr. X-ray diffraction data were obtained on the films before and after the damage irradiations using either a Read or Seemann-Bohlin camera.

The dependence of  $T_c$  upon <sup>4</sup>He damage for the four sets of A15 films is shown in Fig. 1. All films show similar behavior. There is an initial plateau region where  $T_c$  is insensitive to low <sup>4</sup>He doses;  $T_c$  then decreases rapidly for doses in the region  $10^{16}$ – $10^{17} \text{ cm}^{-2}$ . Beyond this, a saturation region is attained where  $T_c$  does not degrade with dose. The 5–95% values of the resistive transitions are plotted except where they are of the order of the size of the data points (midpoints of the transitions). The initial, undamaged  $T_c$  values of the films and final saturated values of  $T_c$  are shown in Table I. The x-ray diffraction data show that after damage the high-angle lines for all materials became more diffuse in nature and that the lattices expanded. Table II shows the lattice parameter,  $a_0$ , of  $\text{Nb}_3\text{Ge}$ ,  $\text{Nb}_3\text{Sn}$ , and  $\text{V}_3\text{Si}$  before bombardment and the amount of lattice expansion,  $\Delta a/a_0$ , when the saturation region has been attained. The relative error in  $\Delta a/a_0$  is  $\sim 30\%$ . The lattice expansion data were not obtained in the  $\text{V}_3\text{Ge}$  case because in the process of etching off the contacts the heavily damaged sample was destroyed.

We will firstly consider the implications of the saturated states and whether they are artifacts of

TABLE II. Lattice parameter expansion following damage to saturation.

	$a_0$ (Å)	$\Delta a/a_0$ ( $10^{-3}$ )
$\text{Nb}_3\text{Ge}$	5.138	10
$\text{Nb}_3\text{Sn}$	5.295	6
$\text{V}_3\text{Si}$	4.727	1.7

$^4\text{He}$  damage as compared to neutron damage. At high  $^4\text{He}$  doses,  $T_c$  saturates as a function of dose for all four compounds with the saturated values given in Table I. This does not necessarily imply that the damage is also saturating as is shown by our x-ray measurements of highly damaged, but initially high- $T_c$   $\text{Nb}_3\text{Ge}$  and  $\text{Nb}_3\text{Sn}$  films and films that have been deposited on room-temperature substrates. The highly damaged films, while displaying considerable disorder, retain some crystallinity whereas the films deposited at room temperature appear much more disordered. However, the  $T_c$ 's of the highly damaged or room-temperature-deposited films are identical (3.5 K for  $\text{Nb}_3\text{Ge}$  and 2.9 K for  $\text{Nb}_3\text{Sn}$ ). For this reason, and because the transitions are narrow in this saturation region, we believe that we are measuring a bulk property. The fact that our transitions are measured resistively, is then not significant when comparing these results with the inductive measurements of the Brookhaven National Laboratory group. Rowell and Schmidt<sup>7</sup> have performed tunneling measurements successfully on  $\text{Nb}_3\text{Ge}$ . Even in the highest  $T_c$  samples, two energy gaps are identified. The larger of these can be associated with well-ordered A15 material. The smaller gap correlates extremely well with our highly damaged state (the gap value,  $2\Delta_L=1.0$  meV, giving  $T_c \sim 3.3$  K).

It is interesting that the saturated  $T_c$  states, whether produced by bombardment or nonoptimum deposition, have identical  $T_c$ 's even though the crystallinity of the films can be very different. This probably indicates that once a sufficient degree of disorder has been introduced,  $T_c$  will degrade no further. Similar highly disordered states for transition metals and transition-metal alloys have been produced by evaporation onto substrates cooled to liquid-helium temperatures.<sup>8</sup> The question still remains as to why the neutron damage apparently reduces  $T_c$  below the limiting values of these highly disordered states. As has been discussed<sup>2,10</sup> previously, the morphology of damage resulting from  $^4\text{He}$  or neutron irradiation should be somewhat different. However, the observation that the depression of  $T_c$  to half in maximum value occurs for approximately the same equivalent doses<sup>2</sup> leads us to believe that there are no gross differences between  $^4\text{He}$  or neutron irradiations.

The damage curves of Fig. 1 show that all four A15's display approximately the same variations in superconducting transition widths as a function of  $^4\text{He}$  dose. The transition widths are very nar-

row in the undamaged and saturated states. In the intermediate region, however, where  $T_c$  is decreasing rapidly with dose, the widths increase quite markedly. This does not appear to be due to experimental artifacts or an intrinsic property of the film, but rather a reproducible physical effect. The widths indicate inhomogeneities in the films on the scale of the coherence length ( $\sim 50$ – $100$  Å), but these inhomogeneities cannot be due to gross changes in composition on that scale ( $^4\text{He}$  damage produces no compositional changes other than minor microscopic rearrangements due to the collision cascade, for example). Instead, it would seem that there are inhomogeneities in the damage densities throughout the films. This can be pictured in terms of the individual collision cascade regions. When the density of cascades is low, there will be an uneven spatial distribution throughout the film due to the statistical nature of the process. At high cascade densities, the statistics improve and damage will be more evenly distributed.

Although the  $T_c$  vs  $^4\text{He}$  dose curves have similar shapes, there are obvious differences in the sensitivity to damage. For example, the doses required to reduce  $T_c$  to 50% of the initial undamaged values are  $2 \times 10^{16}$   $\text{cm}^{-2}$  ( $\text{Nb}_3\text{Ge}$ ),  $5 \times 10^{16}$  ( $\text{Nb}_3\text{Sn}$ ), and  $10^{17}$  ( $\text{V}_3\text{Si}$ ). This sensitivity to damage probably reflects the intrinsic structural stability of the materials, with  $\text{Nb}_3\text{Ge}$  being the most unstable.

In our earlier studies<sup>4</sup> of Nb-Ge films we demonstrated that  $T_c$  was rather insensitive to composition changes for essentially single-phase material. Even at Nb:Ge composition ratios of 4:1 a  $T_c$  of 12 K was obtained. The present studies of the Nb-Sn system show very similar trends. The implications of these data are surprising. Either considerable densities of antistructure defects are possible or the A15 structures can accommodate vacancy or interstitial concentrations of 20 at.% and greater. This last possibility appears physically implausible. If we accept then that such a high density of antistructure defects is possible, we are faced with equally intriguing possibilities. For example,  $T_c$ 's  $\sim 16$  K are possible for Nb:Sn  $\sim 2.5$ . This ratio implies 5% of the sites on the Nb chains are occupied by Sn atoms.  $T_c$  therefore does not appear to be crucially dependent on the integrity of the Nb chains although some dependence clearly may exist.

An interesting correlation has emerged from the  $T_c$  versus stoichiometric dependences of Nb-Ge and Nb-Sn.  $T_c$  appears to be optimized at

composition ratios as low as 2.7:1 instead of the canonical 3:1. It has been suggested<sup>9</sup> that oxygen impurities are needed to stabilize the high- $T_c$  Nb<sub>3</sub>Ge films and that oxygen can be incorporated in the A15 structure at high levels to compensate for the above stoichiometric variations. Our Rutherford-backscattering and nuclear-reaction studies show no evidence for this contention. The combined total of light impurities such as C, N, and O are at low levels (< 2 at.%) in the high- $T_c$  films. It is, of course, well known that defects or impurities can stabilize phases. The present observation that  $T_c$  appears to be optimized at composition ratios of 2.7:1 instead of 3:1 may indicate that lattice stabilization is effected by the simple mechanism of replacing 3% of the Nb atoms with Ge or Sn atoms. Antistructure defects may be stabilizing the lattice. They do not, however, lead to large reductions in  $T_c$ .

In summary, therefore, the introduction of defects in the A15 superconductors produces a certain universality of behavior with regard to (a)  $T_c$  degradation, (b) formation of the saturated state, (c) lattice parameter expansion, and (d) resistance ratio correlations.<sup>2,4,11</sup> It seems unlikely that antistructure (antisite) defects alone are responsible for such universality. Probably any type of defect, in sufficient density, will affect  $T_c$ , for example. The lack of strong correlation of  $T_c$  with stoichiometry in Nb-Ge and Nb-Sn suggests that  $T_c$  is not crucially dependent on the integrity of the Nb chains. The integrity of the overall lattice structure must, however, be maintained; otherwise  $T_c$  will degrade as has been

demonstrated in the present correlations.

Further descriptions of this work will be given elsewhere.<sup>10</sup> We are indebted to D. E. Cox and A. R. Sweedler for illuminating discussions, to A. R. Storm for the x-ray measurements, and to W. M. Augustyniak for expert technical assistance on the accelerator.

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